

Microscopes



Measuring and inspection microscopes with different configurations for semiconductors / MEMS applications. They are characterized by the highest optical performance with fast and easy operation.

[More Information](#)

Inspection & Metrology



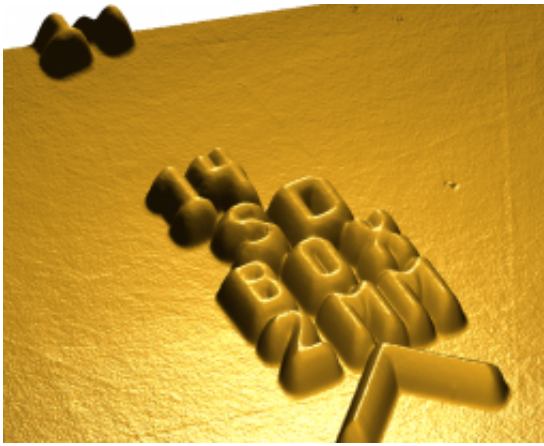
PROMIS

Promicon Inspections & Metrology Systems

- Fully automatic
- Flexible use
- For Inspection and Metrology

[More Information](#)

White Light Interference

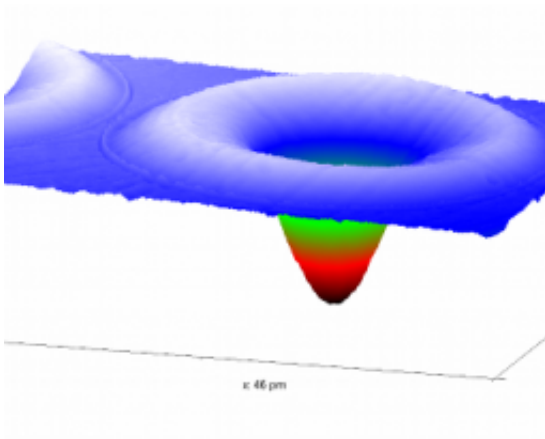


PRO-WLI

Microscope equipment based on INM200/Ergoplan or DM8000 with interferometer hardware & software for topography measurement and export of 3D data.

[More Information](#)

Confocal Microscopy

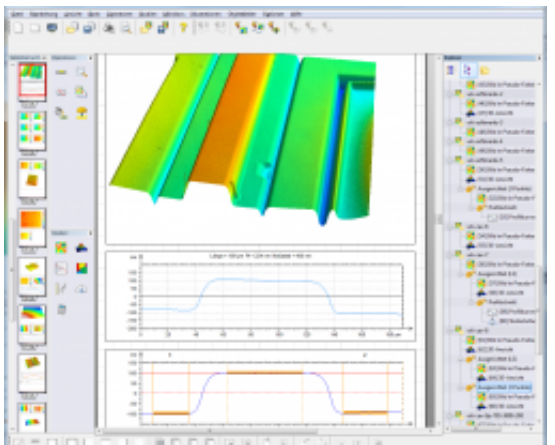


PRO-CON

Microscope confocal module as an upgrade for high resolution 3D Metrology.

[More Information](#)

Software MCS

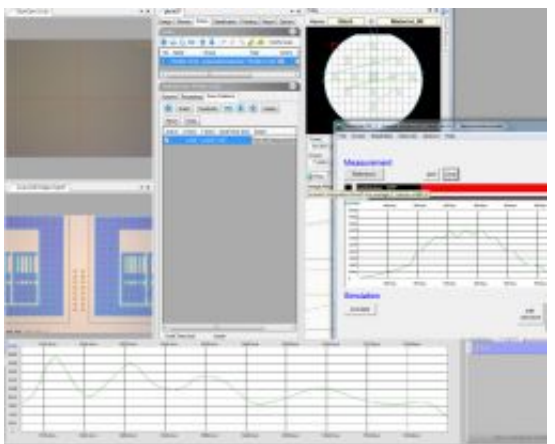


Modular Software Suite MCS:

- Inspection
- Review
- Metrology (CD, confocal,...)
- Hardware control

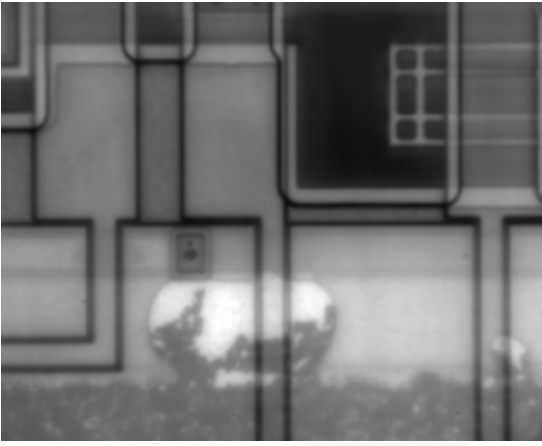
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Thin Film Measurement



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Infrared Systems



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